

AYON

AFGH4L40T120RW-STD

Description

Using the novel field stop 7th generation IGBT technology in TO247 4 lead package, this device of

AFGH4L40T120RW-STD

THERMAL CHARACTERISTICS

Parameter	Symbol	Value
Thermal Resistance, Junction-to-Case for IGBT	$R_{ heta JC}$	0.36
Thermal Resistance, Junction-to-Ambient	$R_{ heta JA}$	40

ELECTRICAL CHARACTERISTICS ($T_J = 25$ C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Collector–to–Emitter Breakdown Voltage	BV _{CES}	$V_{GE} = 0 \text{ V}, I_{C} = 1 \text{ mA}$	1200	-	-	V
Zero Gate Voltage Collector Current	I _{CES}	V _{GE} = 0 V, V _{CE} = V _{CES}	-	-	40	μΑ
Gate-to-Emitter Leakage Current	I _{GES}	V _{GE} = 20 V, V _{CE} = 0 V	_			

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ELECTRICAL CHARACTERISTICS ($T_J = 25$ C unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Тур	Max	Unit
SWITCHING CHARACTERISTIC	S (Note: Si Diode App	lied)				
Turn-On Delay Time	t _{d(on)}	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$	-	41.4	-	ns
Turn-Off Delay Time	t _{d(off)}	$I_C = 20 \text{ A}, R_G = 6 \Omega,$ $T_J = 175 \text{ C}$	-	270	-	
Rise Time	t _r	·	-	25.5	-	
Fall Time	t _f		-	284	-	
Turn-On Switching Loss	E _{on}		-	1	-	mJ
Turn-Off Switching Loss	E _{off}		-	1.81	-	
Total Switching Loss	E _{ts}		-	2.81	-	
Turn-On Delay Time	t _{d(on)}	$V_{CE} = 600 \text{ V}, V_{GE} = 15 \text{ V},$ $I_{C} = 40 \text{ A}, R_{G} = 6 \Omega,$ $T_{J} = 175 \text{ C}$	-	46.4	-	ns
Turn-Off Delay Time	t _{d(off)}		-	211	-	
Rise Time	t _r		_	38	-	
Fall Time	t _f		_	168	-	
Turn-On Switching Loss	E _{on}		-	3.05	-	mJ
Turn-Off Switching Loss	E _{off}		_	2.15	-	
Total Switching Loss	E _{ts}		_	5.19	_	

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TYPICAL CHARACTERISTICS



Figure 7. Capacitance Characteristics

Figure 8. Gate Charge Characteristics



